

HC032N120E7T

1200V N-Channel SiC MOSFET

产品特点/Product features

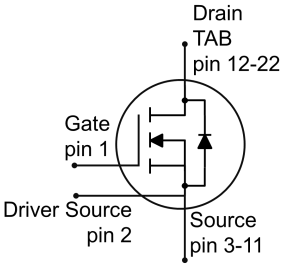
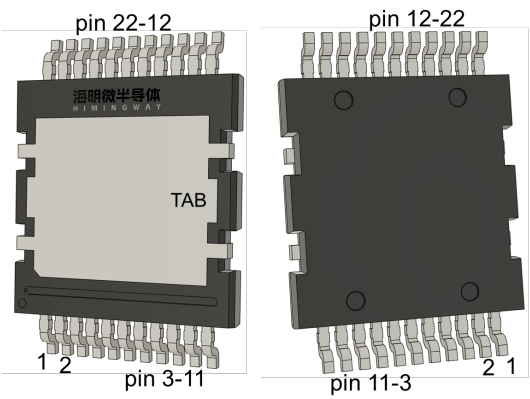
- Top side cooling structure
顶部散热结构
- High Efficiency & Low Loss Performance
高效率与低损耗性能
- Optimized High-Frequency Switching
优化的开关性能与高频率支持
- High Power Density
高功率密度
- Enhanced Drive Stability (Kelvin Source)
增强的驱动稳定性（开尔文源极）
- Simplification & Cost Reduction
系统简化与成本降低
- The device is RoHS Compliant
符合 RoHS 标准

应用领域/Applications

- General Power Supply & Industrial Drives
通用电源与工业驱动
- Energy Storage & Battery Management
能源存储与电池管理
- Renewable Energy & Grid Integration
新能源发电与电网接入
- EV Energy Infrastructure
电动汽车能源基础设施
- Specialized Industrial Power Applications
特殊工业电源应用

关键性能参数/Key Performance Parameters

Parameter	Value	Unit
V_{DS}	1200	V
$R_{DS(on),typ}$	32	mΩ
I_{DM}	211	A



Type/型号	Package/封装	Marking/标识	Packaging method/包装方式
HC032N120E7T	QDPAK	HC032N120T	Tape and Reel/卷带包装

1200V N-Channel SiC MOSFET

HC032N120E7T



1. Maximum ratings at $T_j = 25^\circ\text{C}$, unless otherwise specified.

最大额定值 默认 $T_j = 25^\circ\text{C}$ 除非另有说明

Table 1 Maximum ratings/最大额定值

Parameter 参数	Symbol 符号	Test conditions 测试条件	Value 值	Unit 单位
Drain-source voltage 漏极-源极电压	V_{DS}	$T_j \geq 25^\circ\text{C}$	1200	V
Drain current ¹ 连续漏极电流	I_D	$T_C = 25^\circ\text{C}, V_{GS} = 18\text{V}$	91	A
		$T_C = 100^\circ\text{C}, V_{GS} = 18\text{V}$	65	
Peak drain current ² 峰值漏极电流	I_{DM}	$T_j \leq 175^\circ\text{C}$	211	A
Continuous diode current ¹ 连续二极管电流	I_S	$T_C = 25^\circ\text{C}, V_{GS} = -4\text{V}$	91	A
Peak diode current ² 峰值二极管电流	I_{SM}	$T_C = 25^\circ\text{C}, V_{GS} = -4\text{V}$	211	A
Maximum gate source voltage 栅源最大电压	$V_{GS,MAX}$		-10~22	V
Recommend gate source voltage 推荐的栅源电压	$V_{GS,op}$		-4~18	V
Avalanche energy, single pulse 单脉冲雪崩能量	E_{AS}	$I_{AS} = 31\text{A}, V_{DD} = 100\text{V}, L = 1.0\text{mH}$	528	mJ
Power dissipation ¹ 总耗散功率	P_{tot}	$T_C = 25^\circ\text{C}$	385	W
		$T_C = 100^\circ\text{C}$	192	

1. Limited by $T_{j(max)}$ /受限于最大结温

2. Pulse width t_p limited by $T_{j(max)}$ /脉宽受限于最大结温



2. Thermal characteristics

热特性

Table 2 Thermal characteristics/热特性

Parameter 参数	Symbol 符号	Test conditions 测试条件	Value/值			Unit 单位
			Min.	Typ.	Max.	
Storage Temperature 存储温度	T_{stg}		-55		175	°C
Operating junction Temperature 工作结温	T_j		-55		175	°C
Thermal resistance, junction-case 结-壳热阻	$R_{th(j-c)}$			0.39		K/W
Thermal resistance, junction-ambient 结-环境热阻	$R_{th(j-a)}$			40		K/W
Soldering temperature, reflow solderin 焊接温度, 回流焊	T_{sold}	reflow MSL1			260	°C



3. Electrical characteristics at $T_j = 25^\circ\text{C}$, unless otherwise specified.

电气特性 默认 $T_j = 25^\circ\text{C}$ 除非另有说明

Table 3 Static characteristics/静态特性

Parameter 参数	Symbol 符号	Test conditions 测试条件		Value/值			Unit 单位
				Min.	Typ.	Max.	
Drain-source breakdown voltage 漏源击穿电压	$V_{(BR)DSS}$	$I_D = 100\mu\text{A}, V_{GS} = 0\text{V}$		1200			V
Gate threshold voltage 门极开启阈值电压	$V_{GS(th)}$	$I_D = 10\text{mA}, V_{DS} = V_{GS}$	$T_j = 25^\circ\text{C}$	1.8	2.5	3.8	V
			$T_j = 175^\circ\text{C}$		1.8		
Drain-source on-state resistance 漏极-源极导通电阻	$R_{DS(on)}$	$I_D = 40\text{A}, V_{GS(on)} = 15\text{V}$	$T_j = 25^\circ\text{C}$		40		m Ω
			$T_j = 175^\circ\text{C}$		60		
		$I_D = 40\text{A}, V_{GS(on)} = 18\text{V}$	$T_j = 25^\circ\text{C}$		32		
			$T_j = 175^\circ\text{C}$		57		
Zero gate voltage drain current 集电极-发射极漏电	I_{DSS}	$V_{DS} = 1200\text{V}, V_{GS} = 0\text{V}$			0.1	10	μA
Gate to source Leakage current 门极-源极漏电流	I_{GSS}	$V_{DS} = 0\text{V}, V_{GS} = 18\text{V}$				100	nA
		$V_{DS} = 0\text{V}, V_{GS} = -4\text{V}$				100	
Forward transconductance 正向跨导	g_{fs}	$I_D = 40\text{A}, V_{DS} = 20\text{V}$	$T_j = 25^\circ\text{C}$		25		S
			$T_j = 175^\circ\text{C}$		27		
Integrated gate resistor 内部门极电阻	R_G	$f = 1\text{MHz}$			0.76		Ω

1200V N-Channel SiC MOSFET HC032N120E7T



Table 4 Dynamic characteristics/动态特性

Parameter 参数	Symbol 符号	Test conditions 测试条件	Value/值			Unit 单位
			Min.	Typ.	Max.	
Total gate charge 总栅极电荷	$Q_{G(tot)}$	$V_{DD}=800V$, $I_D=40A$, $V_{GS}=-4/18V$		88		nC
Gate source charge 栅-源极电荷	Q_{GS}			22		
Gate-drain charge 栅-漏极电荷	Q_{GD}			35		
Input capacitance 输入电容	C_{iss}	$V_{DS}=1000V$, $V_{GS}=0V$, $f=100KHz$		1855		pF
Output capacitance 输出电容	C_{oss}			91		
Reverse transfer capacitance 反向传输电容	C_{rss}			6.6		
Coss stored energy 输出电容存储能量	E_{oss}	Calculated based on C_{oss}		36		μJ

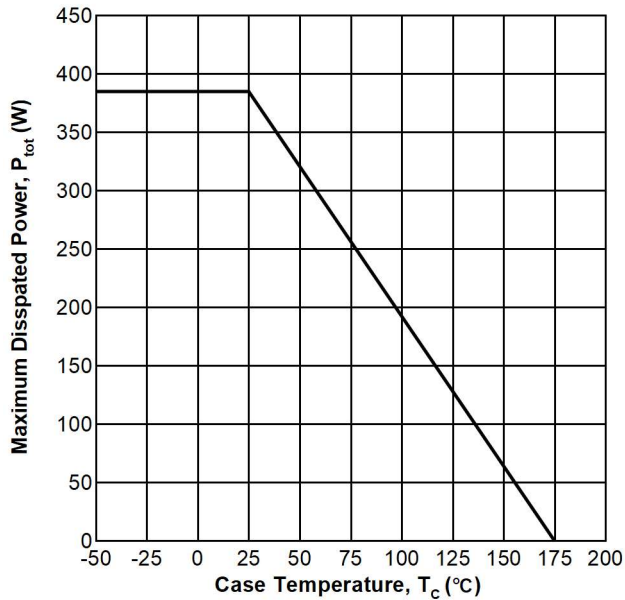
Table 5 Reverse diode characteristics/体二极管反向特性

Parameter 参数	Symbol 符号	Test conditions 测试条件	Value/值			Unit 单位
			Min.	Typ.	Max.	
Drain-source reverse voltage 体二极管正向压降	V_{SD}	$I_S=20A, V_{GS}=0V$		3.1		V
		$I_S=20A, V_{GS}=-2V$		3.6		
		$I_S=20A, V_{GS}=-5V$		3.8		

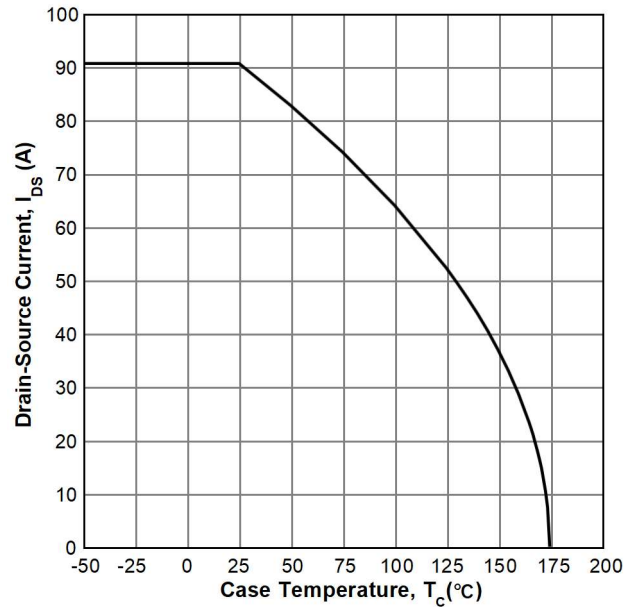
4. Electrical characteristics diagrams

电气特性图表

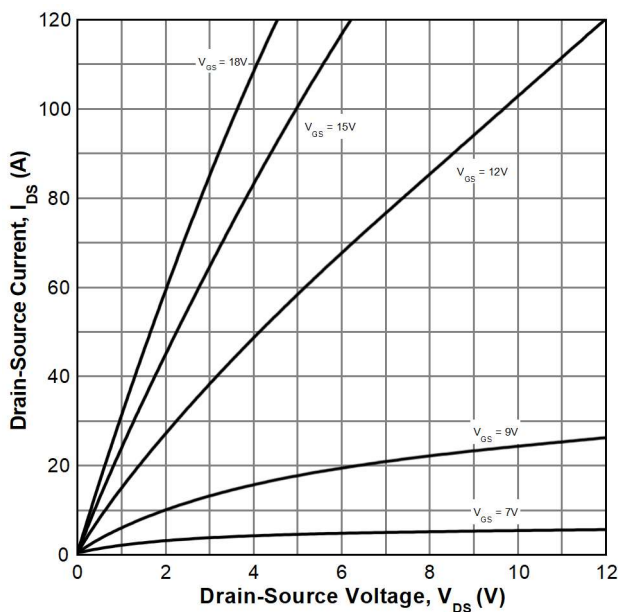
Power dissipation/耗散功率
 $P_{tot}=f(T_c)$; $T_J \leq 175^\circ\text{C}$



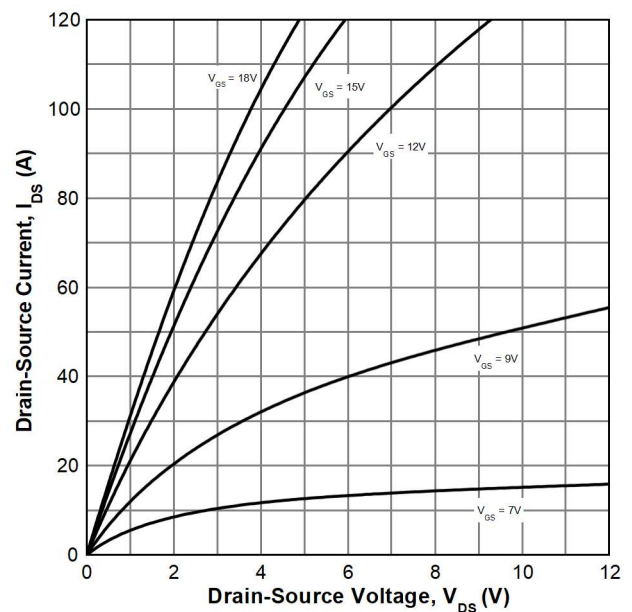
Continuous Drain Current/连续漏电流与壳温
 $I_{DS}=f(T_c)$; $T_J \leq 175^\circ\text{C}$



Typ. Output Characteristic/典型输出特性
 $I_{DS}=f(V_{DS})$; $T_J = -55^\circ\text{C}$

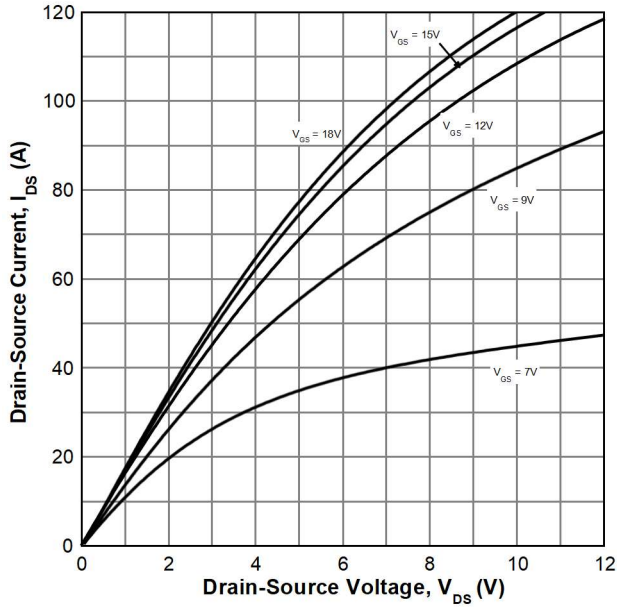


Typ. Output Characteristic/典型输出特性
 $I_{DS}=f(V_{DS})$; $T_J = 25^\circ\text{C}$

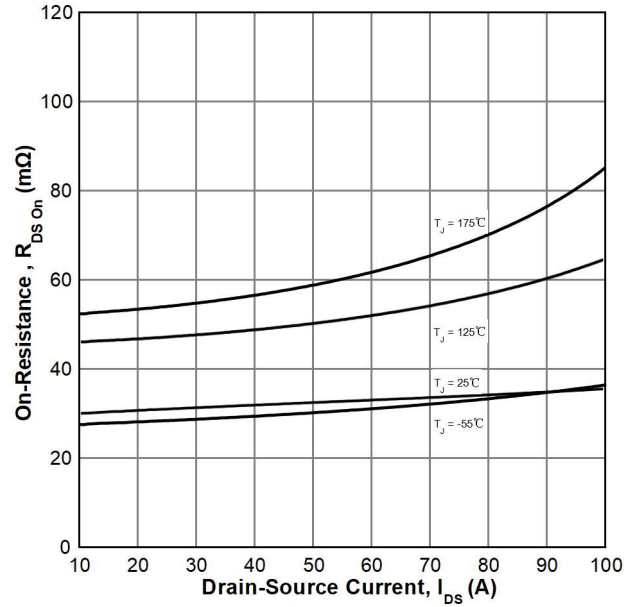




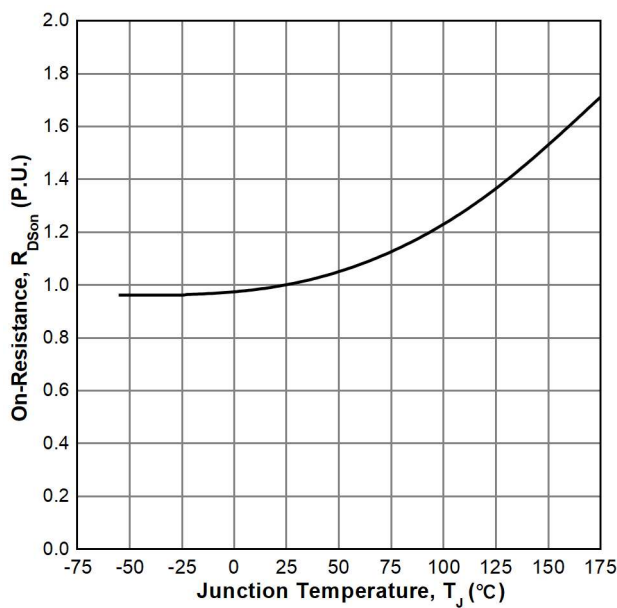
Typ. Output characteristic/典型输出特性
 $I_{DS}=f(V_{DS})$; $T_J=175^{\circ}\text{C}$



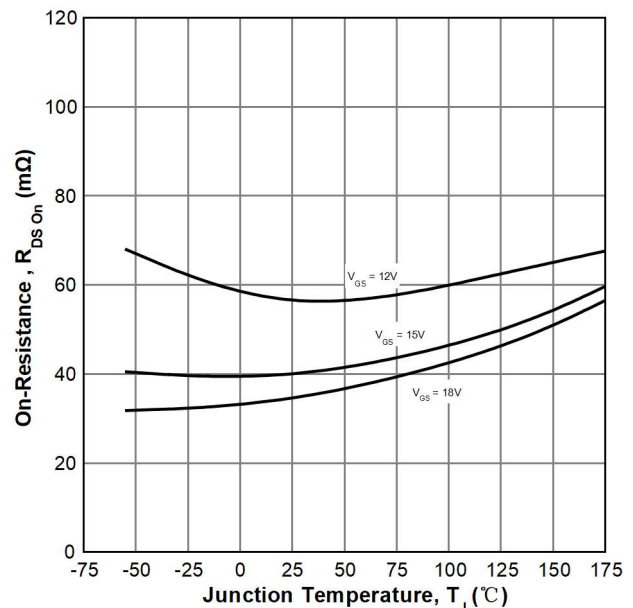
Typ. Drain-source on-state resistance/典型漏源导通电阻
 $R_{DS(on)}=f(I_{DS})$; $V_{GS}=18\text{V}$, $I_{DS}=40\text{A}$



Typ. Drain-source on-state resistance/漏源导通电阻
 $R_{DS(on)}=f(T_J)$; $I_{DS}=40\text{A}$, $V_{GS}=18\text{V}$

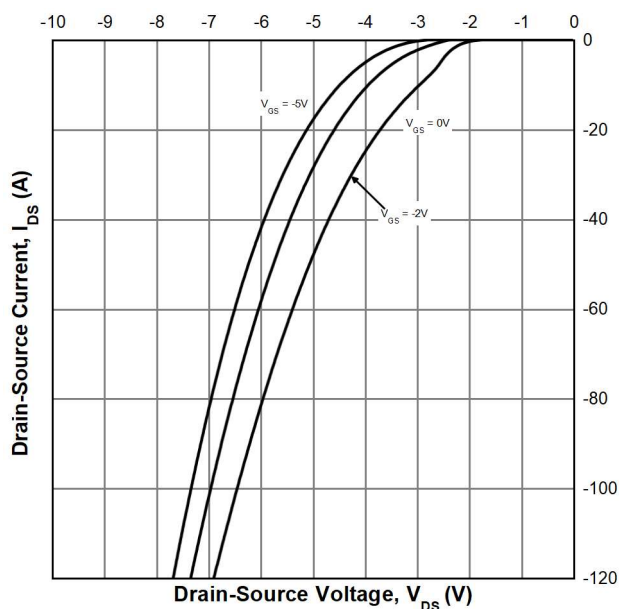


Typ. Drain-source on-state resistance/漏源导通电阻
 $R_{DS(on)}=f(T_J)$; $I_{DS}=40\text{A}$

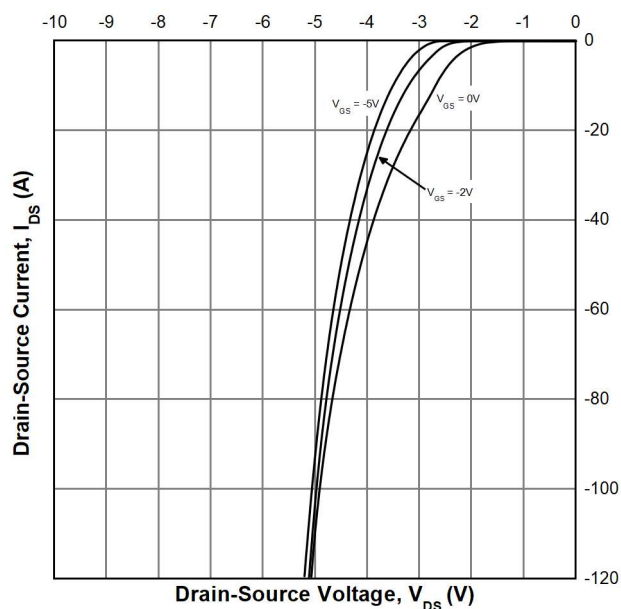




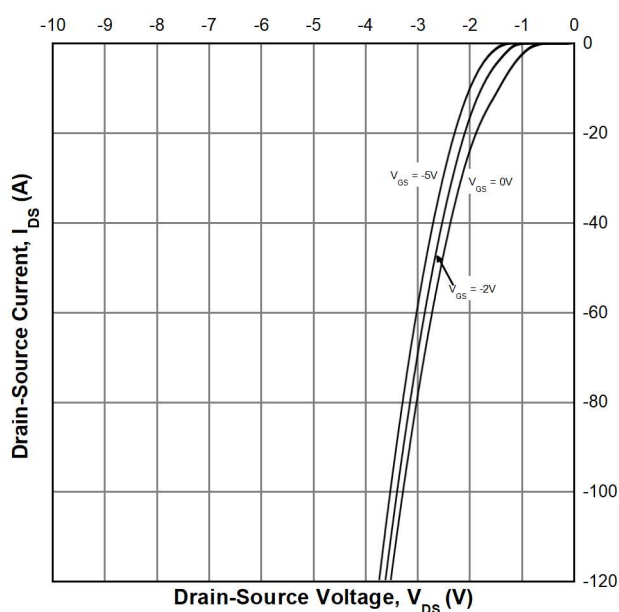
Typ.Reverse drain current characteristics/典型体二极管特性
 $I_{SD}=f(V_{SD})$; $T_J=-55^{\circ}\text{C}$



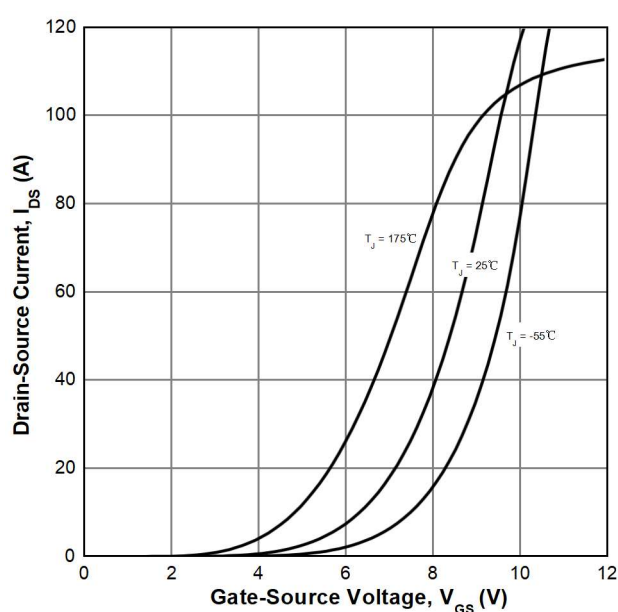
Typ.Reverse drain current characteristics/典型体二极管特性
 $I_{SD}=f(V_{SD})$; $T_J=25^{\circ}\text{C}$



Typ.Reverse drain current characteristics/典型体二极管特性
 $I_{SD}=f(V_{SD})$; $T_J=175^{\circ}\text{C}$



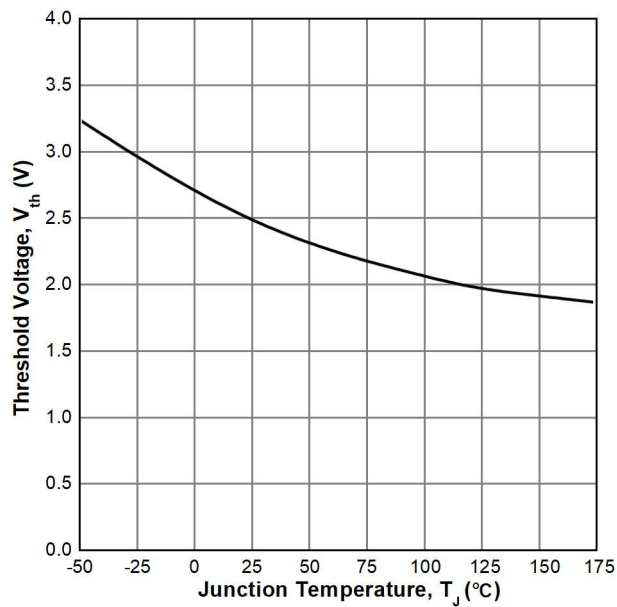
Typ.Transfer characteristics/传输特性
 $I_{DS}=f(V_{GS})$; $V_{DS}=20\text{V}$



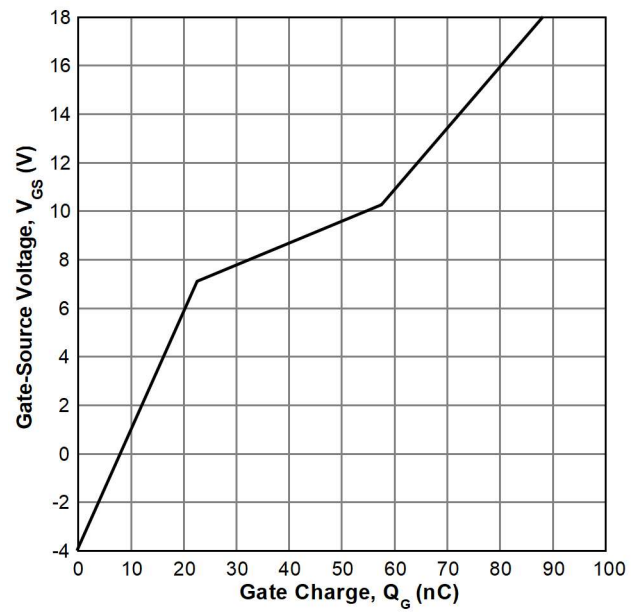
1200V N-Channel SiC MOSFET
HC032N120E7T



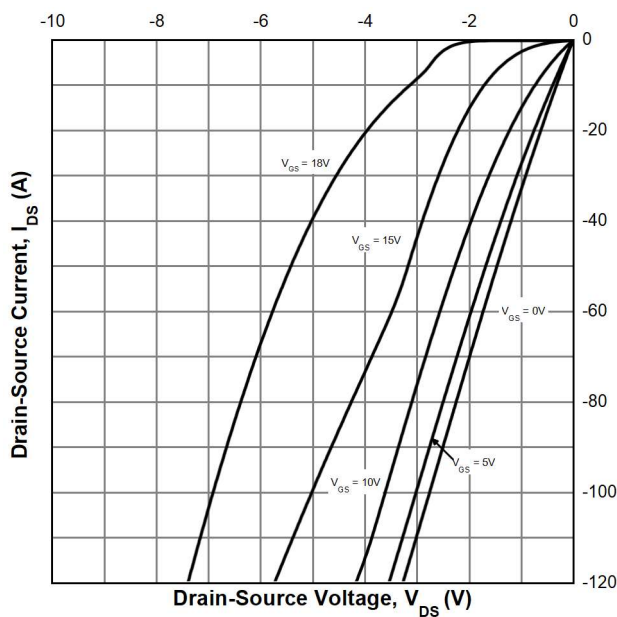
Typ. Gate threshold voltage/门级阈值电压结温特性
 $V_{GS}=f(T_J)$; $I_D=10mA$, $V_{DS}=V_{GS}$



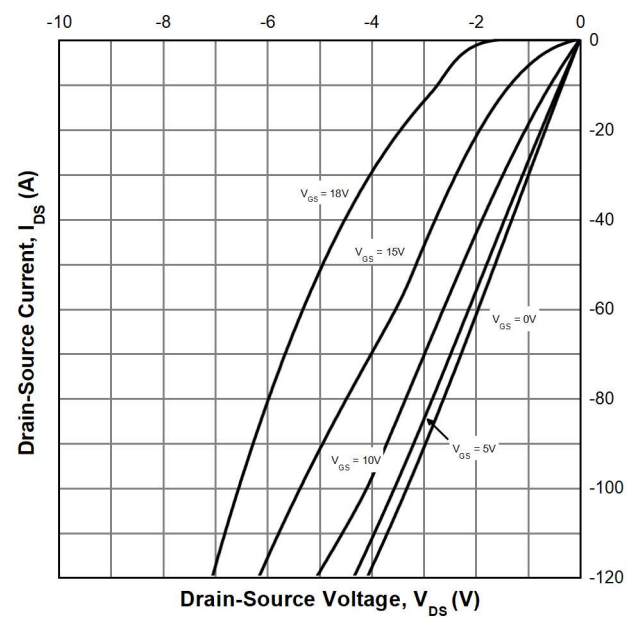
Typ. Gate charge/典型门级电荷
 $V_{GS}=f(Q_G)$; $I_{DS}=40A$, $I_{GS}=50mA$, $V_{DS}=800V$, $T_J=25^\circ C$



Typ. 3rd Quadrant Characteristics/典型第三象限特性
 $I_{DS}=f(V_{DS})$; $T_J=-55^\circ C$



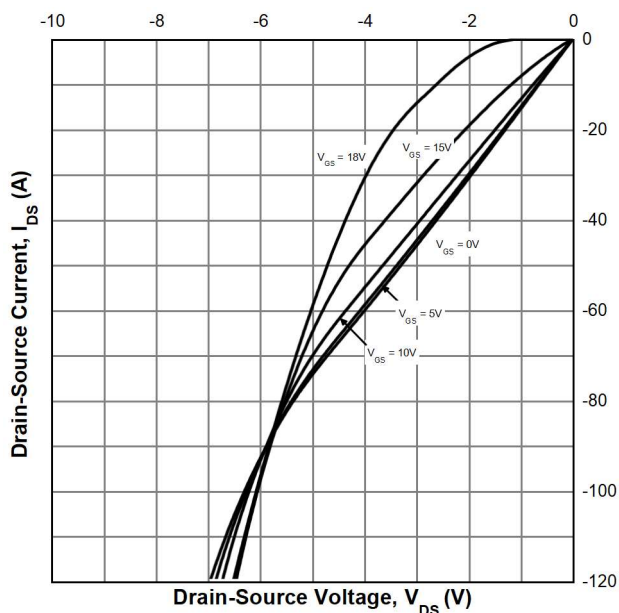
Typ. 3rd Quadrant Characteristics/典型第三象限特性
 $I_{DS}=f(V_{DS})$; $T_J=25^\circ C$



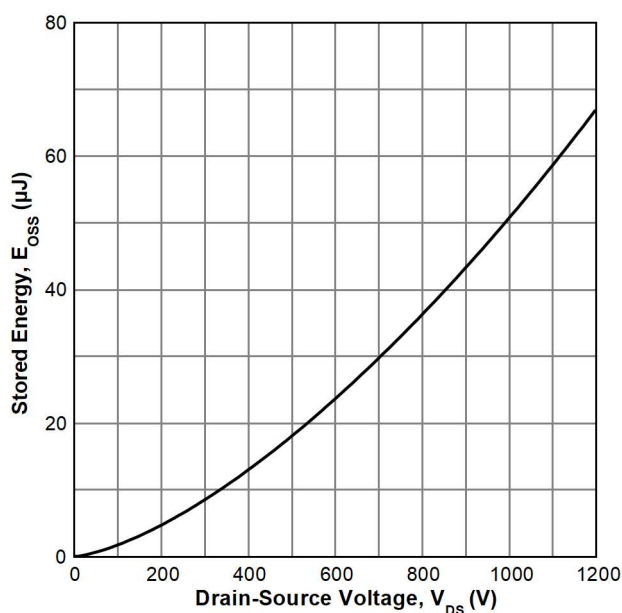
1200V N-Channel SiC MOSFET HC032N120E7T



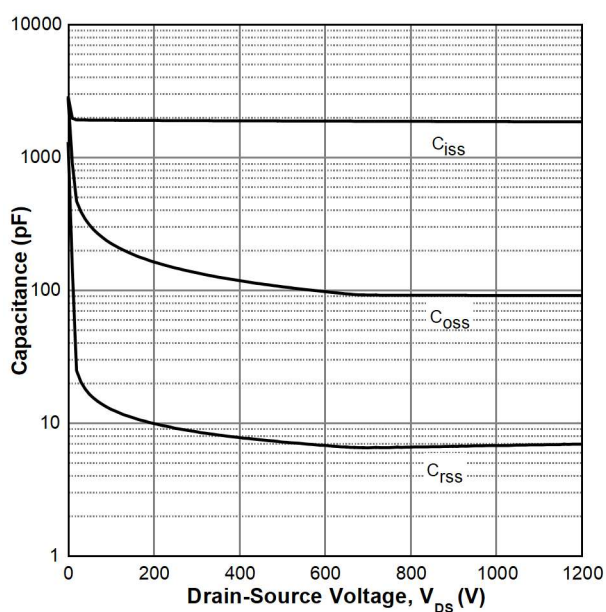
Typ.3rd Quadrant Characteristics/典型第三象限特性
 $I_{DS}=f(V_{DS})$; $T_J=25^\circ\text{C}$



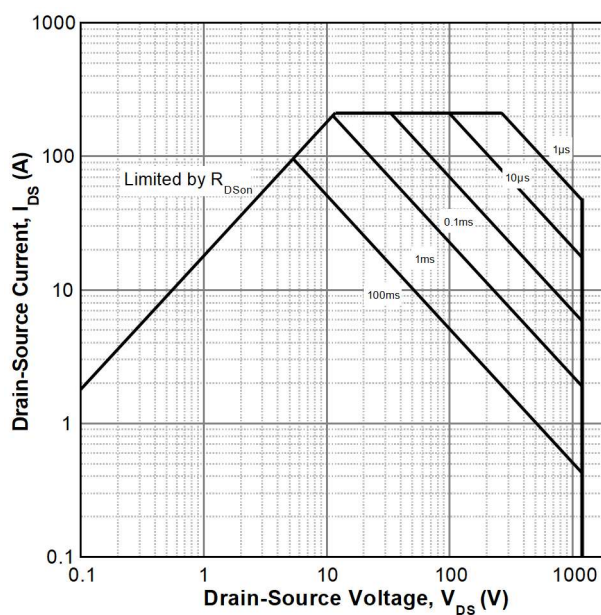
Typ.Coss stored energy/典型 C_{OSS} 存储能量
 $E_{OSS}=f(V_{DS})$; $T_J=25^\circ\text{C}$



Typ.Capacitances/典型电容特性
 $C=f(V_{DS})$; $V_{GS}=0\text{V}$, $T_J=25^\circ\text{C}$



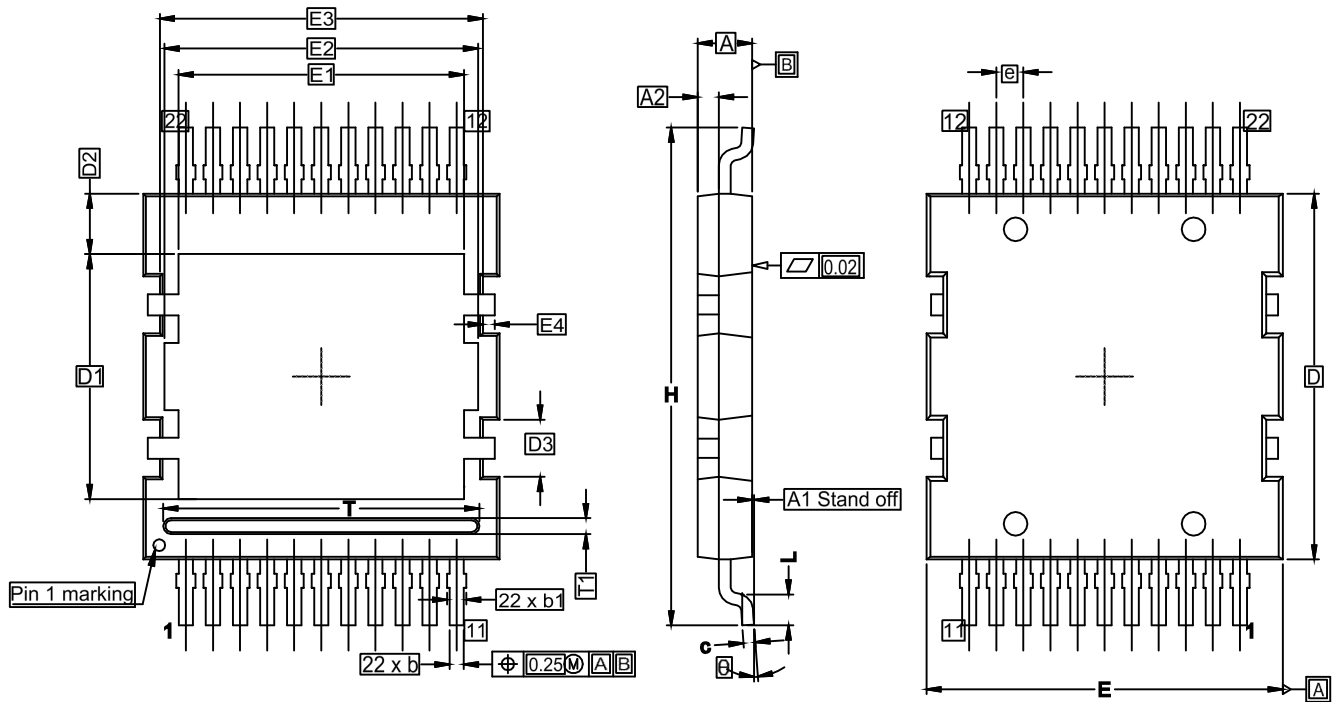
Forward bias safe operating area/安全工作区
 $I_D=f(V_{DS})$; $T_C=25^\circ\text{C}$, $D=0$



5. Package outline

封装外形

Figure 1. Outline QDPAK-22, dimensions in mm/QDPAK-22外形尺寸 (毫米)



DIM SYMBOL	MIN.	NOM.	MAX.
A	2.20	2.30	2.35
A1	0.00	---	0.15
A2	0.80	0.90	1.00
b	0.50	0.60	0.70
b1	0.50	---	0.90
c	0.46	0.50	0.58
e	1.140 BSC		
D	15.30	15.40	15.50
D1	10.23	10.32	10.43
D2	2.540 REF.		
D3	2.400 REF.		
E	14.90	15.00	15.10
E1	11.91	12.01	12.11
E2	13.200 REF.		
E3	13.600 REF.		
E4	0.500 REF.		
H	20.81	20.96	21.11
L	1.20	1.30	1.40
Θ	0°	---	8°
T	13.21	13.31	13.41
T1	0.50	0.67	0.70

NOTES/注:
ALL METAL SUFACES ARE TIN PLATED,EXCEPT AREA OF CUT.
除切割区域外,所有金属表面均为镀锡。



6. Revision history

Table 6 Date and version number/日期与版本号

Date日期	Revision版本	Changes更改内容
2025-09-15	Rev. G 1.0	Target Datasheet (目标规格书)

7. Matters needing attention

Appendix 1. Important Technical Guidance, Application Policy, and Copyright Notice/重要技术指南、应用规范与版权声明

[Data and Design Guidance]

The information provided herein, including typical values and application examples, serves as technical guidance only and should not be construed as a formal guarantee of product characteristics. This documentation is intended for qualified engineering personnel, who bear the ultimate responsibility for evaluating the product's suitability for their specific application and compliance with all industry standards.

[Copyright and Revision Management]

We reserve all rights to the intellectual property contained within this document, and unauthorized reproduction is prohibited. For the sake of continuous improvement, the content is subject to change without prior notice. Designers are obligated to consult and use the latest revision of this datasheet to ensure optimal performance and accuracy in their final product.

[Application Safety and Intellectual Property]

Our product supply does not confer any license or right under any third-party intellectual property. Customers are fully responsible for the patent clearance and functional safety of their end application. Furthermore, this product is not intended for use in life-critical or high-risk systems (such as Class III medical devices or aerospace control) unless explicitly approved by us through a dedicated high-reliability agreement.

【数据与设计指引】

本文件中提供的所有信息，包括任何典型值和应用示例，仅作为技术指引，不应被视为对产品特性的正式保证。本资料专供具备资质的工程技术人员使用，客户的技术部门应对产品在特定应用中的适用性和对所有行业标准的符合性负最终评估责任。

【版权与版本管理】

本文件的所有知识产权和版权均归我方所有，严禁未经授权的复制与传播。为持续优化产品性能，本文件内容可能随时变更，恕不另行通知。设计人员有义务查阅并使用最新的版本数据手册，以确保设计准确性并实现最佳系统性能。

【应用安全与知识产权】

我方提供本产品，不应被视为授予任何第三方知识产权的许可或权利。客户应对其终端应用中的功能安全性、系统鲁棒性以及不侵犯任何第三方专利负全部责任。此外，本产品未被设计或认证用于生命维持或极高风险的关键系统。在将本产品用于此类高可靠性应用之前，客户必须设计充分的冗余和安全机制，并事先与我方签署专门的高可靠性供货协议。

<http://www.hmwsemi.com/>